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Docket Number (Optional) Application Number 2003UR034 Unassigned Applicants David S. Frankel Group Art Unit Filing Date

Unassigned

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*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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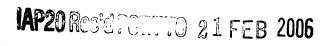
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